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Accreditation No.: **SCS 0108**

Client **BACL**
 Sunnyvale, USA

Certificate No. **EX-7520_Dec25**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN:7520**

Calibration procedure(s) **QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,
 QA CAL-25.v8, QA CAL-48.v2
 Calibration procedure for dosimetric E-field probes**

Calibration date **December 22, 2025**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
 All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3) °C and humidity < 70%.
 Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP40T	SN: 101861	29-Apr-25 (No. 2025-001450)	Apr-26
N-type mismatch combination	SN: L1119	26-Mar-25 (No. 217-04292)	Mar-26
OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26
OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	30-Oct-25 (No. DAE4-1301_Oct25)	Oct-26

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Setup 1	SN: L1404	01-Oct-25 (No. IHCK_ACAP2020-1_Oct25)	Oct-26
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCP DAK-3.5	SN: 1336	10-Dec-25 (No. OCP-DAK3.5-1336_Dec25)	Dec-26

	Name	Function	Signature
Calibrated by	Joanna Lleshaj	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: December 23, 2025

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Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

Parameters of Probe: EX3DV4 - SN:7520

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc ($k = 2$)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.59	0.62	0.56	$\pm 10.1\%$
DCP (mV) ^B	103.7	102.7	107.3	$\pm 4.7\%$

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B $\text{dB}\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E $k = 2$
0	Continuous Wave	X	0.00	0.00	1.00	0.00	146.9	$\pm 1.2\%$	$\pm 4.7\%$
		Y	0.00	0.00	1.00		129.7		
		Z	0.00	0.00	1.00		149.0		
10352	Pulse (D=10%, T=5 ms)	X	0.55	70.00	18.25	10.00	23.0	$\pm 1.7\%$	$\pm 9.6\%$
		Y	0.21	59.65	14.59		24.0		
		Z	0.26	59.86	14.82		23.0		
10353	Pulse (D=20%, T=5 ms)	X	0.51	73.01	18.30	6.99	46.0	$\pm 1.4\%$	$\pm 9.6\%$
		Y	0.19	62.66	14.62		48.0		
		Z	0.24	62.87	14.87		46.0		
10354	Pulse (D=40%, T=5 ms)	X	0.47	76.02	18.34	3.98	92.0	$\pm 1.2\%$	$\pm 9.6\%$
		Y	0.18	65.67	14.65		96.0		
		Z	0.22	65.88	14.92		92.0		
10355	Pulse (D=60%, T=5 ms)	X	0.45	77.78	18.37	2.22	138.0	$\pm 1.2\%$	$\pm 9.6\%$
		Y	0.17	67.43	14.67		144.0		
		Z	0.21	67.64	14.96		138.0		
10387	Random (BW=1 MHz, MOD=QPSK)	X	0.00	74.90	19.57	0.19	107.0	$\pm 1.5\%$	$\pm 9.6\%$
		Y	0.01	64.55	15.70		112.0		
		Z	0.00	64.76	16.31		107.0		
10388	Random (BW=10 MHz, MOD=QPSK)	X	1.58	74.78	17.60	0.00	113.0	$\pm 2.6\%$	$\pm 9.6\%$
		Y	0.61	64.43	13.79		119.0		
		Z	0.59	64.65	14.08		113.0		
10396	Random (BW=100 kHz, MOD=64QAM)	X	0.00	73.73	20.56	1.60	80.0	$\pm 3.5\%$	$\pm 9.6\%$
		Y	0.00	63.37	16.98		84.0		
		Z	0.00	63.59	17.70		80.0		
10399	Random (BW=40 MHz, MOD=64QAM)	X	3.74	73.73	17.48	0.00	105.0	$\pm 3.9\%$	$\pm 9.6\%$
		Y	1.64	63.37	12.91		111.0		
		Z	1.65	63.59	12.99		105.0		
10414	Random (BW=40 MHz, HIGH PAR)	X	4.59	71.46	17.48	0.00	77.0	$\pm 1.8\%$	$\pm 9.6\%$
		Y	2.03	61.11	12.82		81.0		
		Z	1.99	61.33	12.90		77.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E^2 -field uncertainty inside TSL (see Pages 5 and 6).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Parameters of Probe: EX3DV4 - SN:7520

Sensor Model Parameters

	C1 fF	C2 fF	α V^{-1}	T1 $ms V^{-2}$	T2 $ms V^{-1}$	T3 ms	T4 V^{-2}	T5 V^{-1}	T6
x	9.8	72.41	34.88	2.60	0.00	4.90	0.30	0.00	1.00
y	8.7	65.18	35.43	2.35	0.00	4.90	0.00	0.00	1.00
z	8.5	61.86	33.62	4.76	0.00	4.92	0.52	0.00	1.00

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle	-87.9°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an *Area Scan* job.

Parameters of Probe: EX3DV4 - SN:7520

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
750	41.9	0.89	9.88	9.42	9.75	0.35	1.27	±11.0%
835	41.5	0.90	9.59	9.15	9.46	0.35	1.27	±11.0%
1450	40.5	1.20	8.11	7.74	8.01	0.34	1.27	±11.0%
1810	40.0	1.40	7.89	7.52	7.78	0.34	1.27	±11.0%
1900	40.0	1.40	7.64	7.28	7.53	0.34	1.27	±11.0%
2300	39.5	1.67	7.48	7.13	7.38	0.34	1.27	±11.0%
2450	39.2	1.80	7.28	6.94	7.18	0.34	1.27	±11.0%
2600	39.0	1.96	7.43	7.08	7.33	0.34	1.27	±11.0%
3300	38.2	2.71	6.60	6.29	6.51	0.34	1.27	±13.1%
3500	37.9	2.91	6.67	6.36	6.58	0.33	1.27	±13.1%
3700	37.7	3.12	6.60	6.29	6.51	0.33	1.27	±13.1%
3900	37.5	3.32	6.57	6.26	6.48	0.33	1.27	±13.1%
5250	35.9	4.71	5.57	5.31	5.49	0.30	1.27	±13.1%
5600	35.5	5.07	5.16	4.92	5.09	0.27	1.27	±13.1%
5750	35.4	5.22	5.28	5.03	5.21	0.26	1.27	±13.1%
5850	35.2	5.32	5.00	4.77	4.93	0.25	1.27	±13.1%

^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

Parameters of Probe: EX3DV4 - SN:7520

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
6500	34.5	6.07	5.25	5.00	5.18	0.20	1.27	±18.6%

^C Frequency validity is -600/+700 MHz at 6.5 GHz, ±700 MHz at or above 7 GHz, and ±150 MHz at 9.85 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

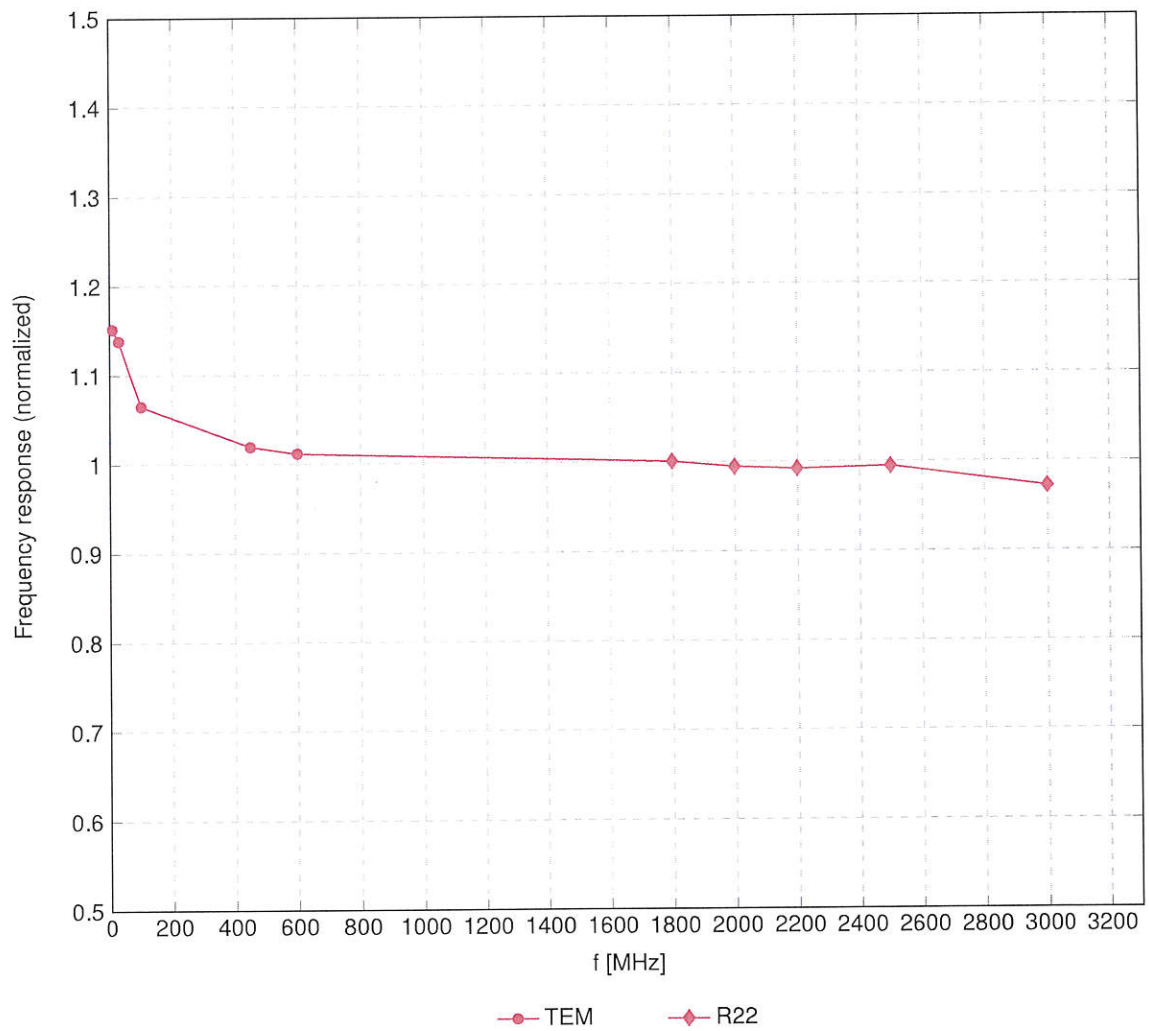
^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±10% from the target values (typically better than ±6%) and are valid for TSL with deviations of up to ±10%.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz; below ±2% for frequencies between 3–6 GHz; and below ±4% for frequencies between 6–10 GHz at any distance larger than half the probe tip diameter from the boundary.

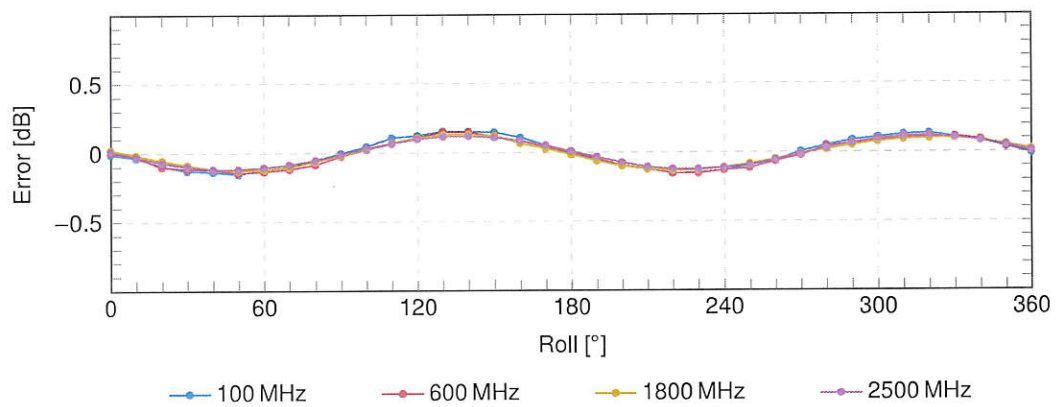
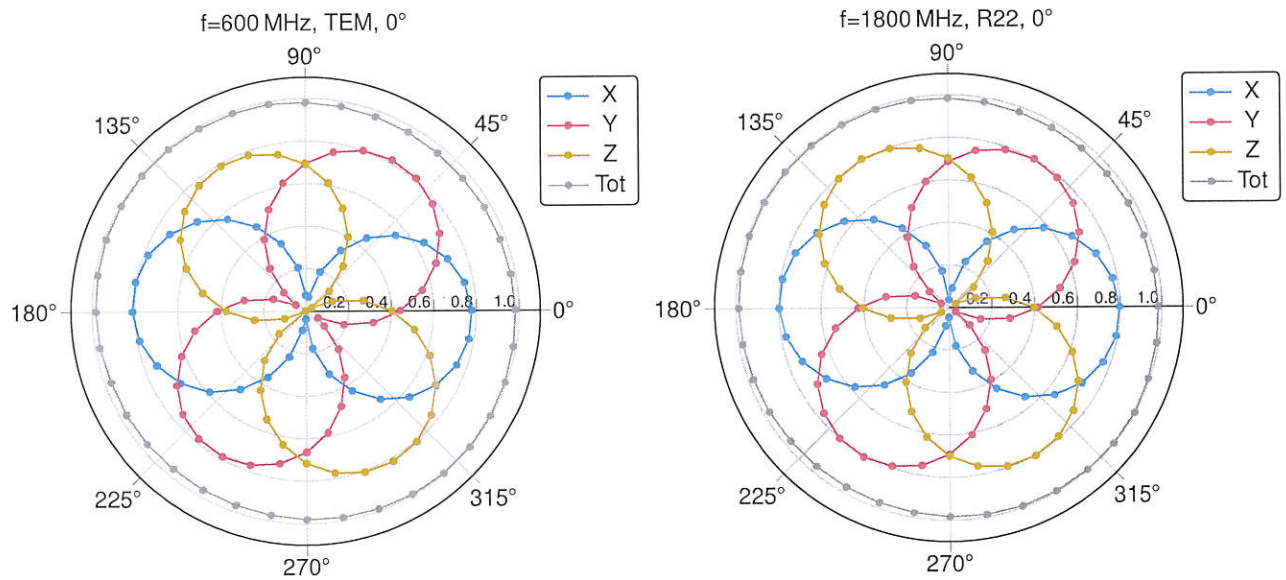
^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

Frequency Response of E-Field

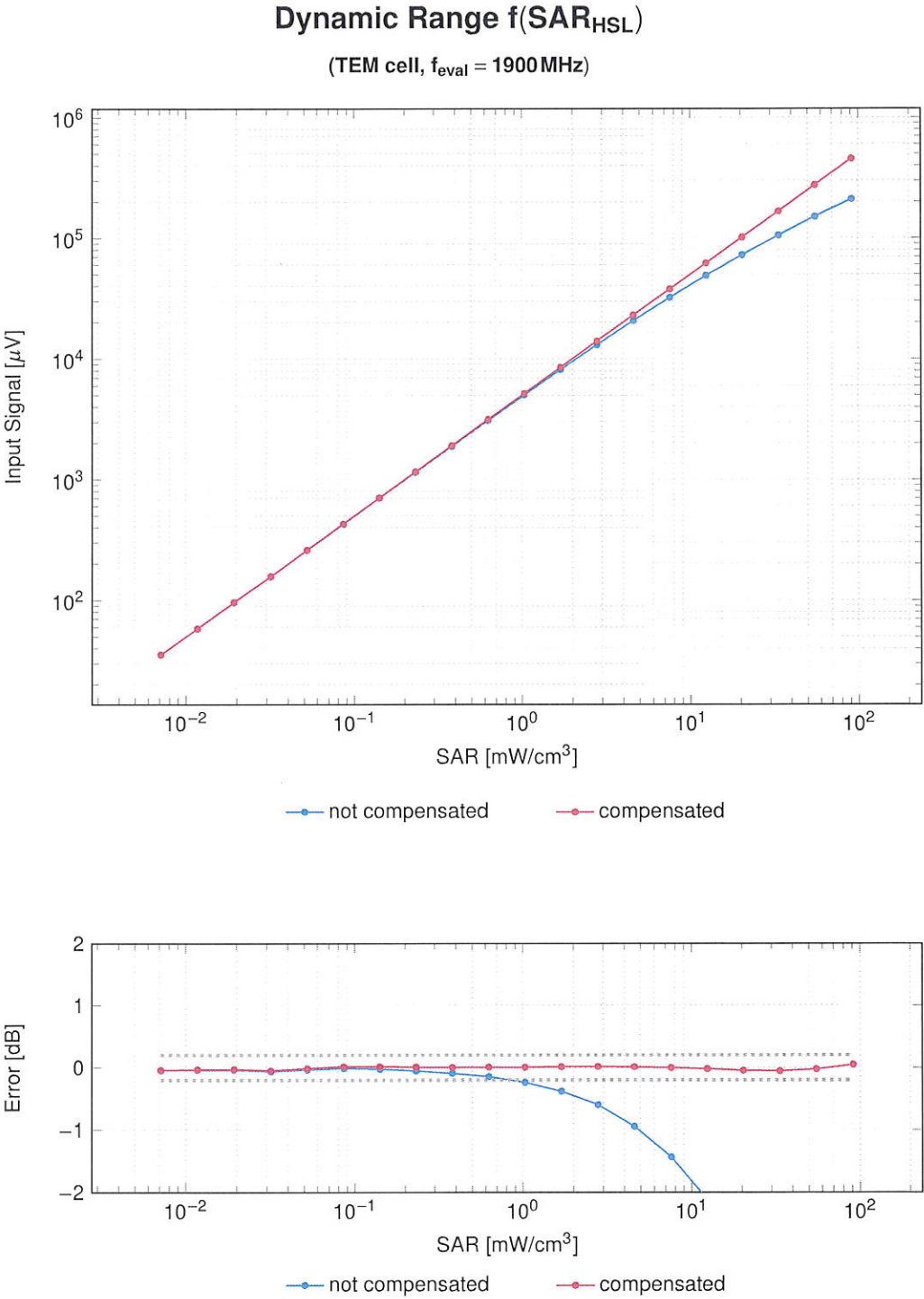
(TEM-Cell:ifi110 EXX, Waveguide:R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

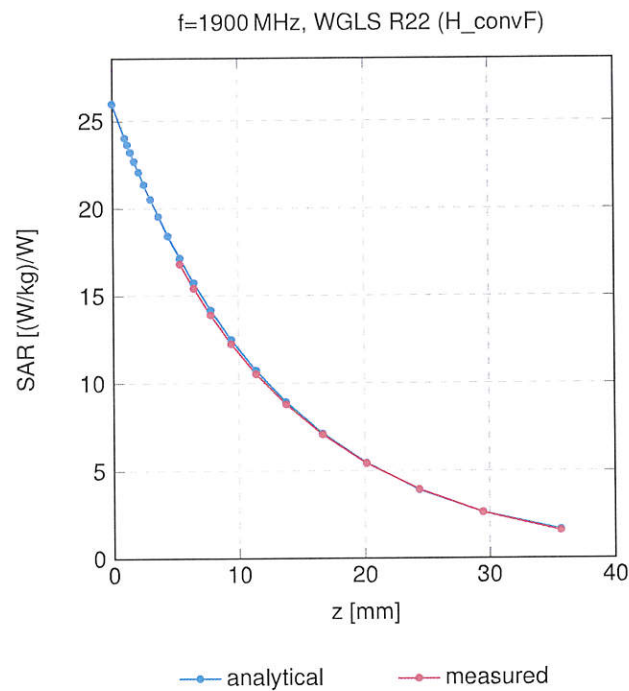
Receiving Pattern (ϕ), $\vartheta = 0^\circ$ 

Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

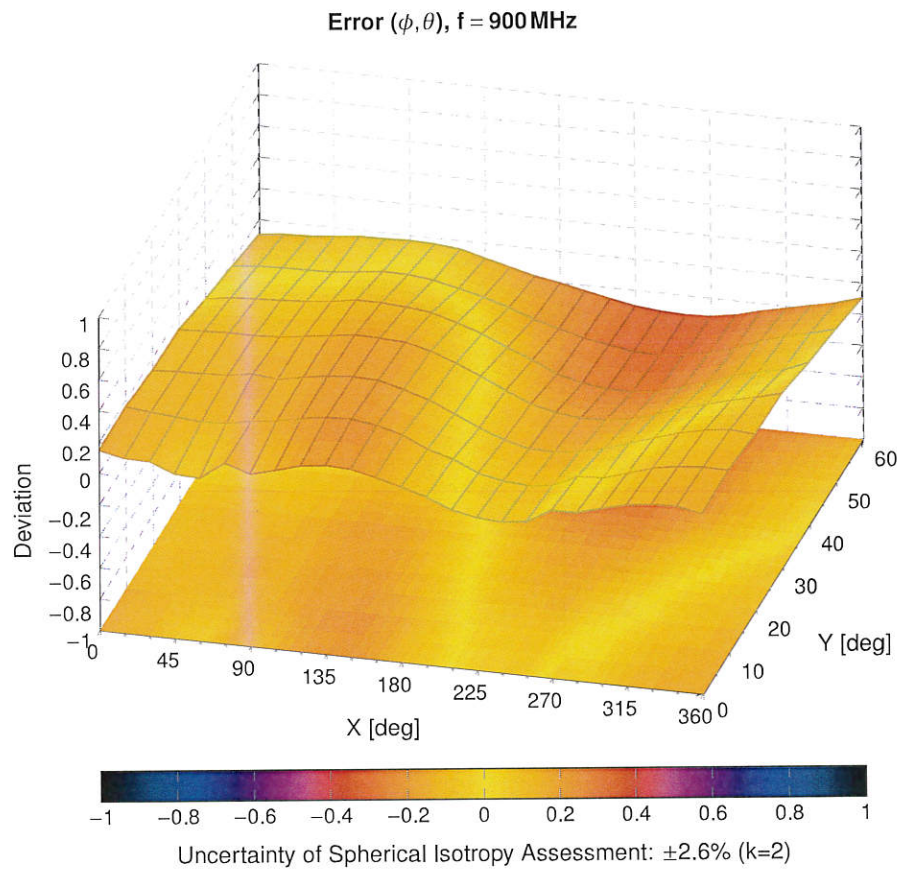


Uncertainty of Linearity Assessment: ±0.6% (k=2)

Conversion Factor Assessment



Deviation from Isotropy in Liquid





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Accreditation No.: SCS 0108

Client **BACL**
Sunnyvale - USA

Certificate No: **DAE4-1561_Dec25**

CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BN - SN: 1561

Calibration procedure(s) QA CAL-06.v30
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: December 03, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	15-Aug-25 (No:43873)	Aug-26
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-25 (in house check)	In house check: Jan-26
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-25 (in house check)	In house check: Jan-26

Calibrated by:	Name	Function	Signature
	Adrian Gehring	Laboratory Technician	
Approved by:	Sven Kühn	Technical Manager	

Issued: December 3, 2025

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Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61 nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	405.649 $\pm$ 0.02% (k=2)	406.168 $\pm$ 0.02% (k=2)	406.041 $\pm$ 0.02% (k=2)
Low Range	3.97291 $\pm$ 1.50% (k=2)	3.98316 $\pm$ 1.50% (k=2)	4.02937 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	223.0 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	199996.23	0.04	0.00
Channel X	+ Input	20003.06	0.88	0.00
Channel X	- Input	-20000.41	2.59	-0.01
Channel Y	+ Input	199994.74	-1.13	-0.00
Channel Y	+ Input	19999.98	-2.02	-0.01
Channel Y	- Input	-20004.15	-1.11	0.01
Channel Z	+ Input	199996.45	0.51	0.00
Channel Z	+ Input	20001.27	-0.70	-0.00
Channel Z	- Input	-20004.89	-1.84	0.01

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2000.41	-0.14	-0.01
Channel X	+ Input	201.06	0.33	0.16
Channel X	- Input	-198.74	0.17	-0.09
Channel Y	+ Input	2000.71	0.24	0.01
Channel Y	+ Input	200.12	-0.48	-0.24
Channel Y	- Input	-199.95	-0.83	0.41
Channel Z	+ Input	2000.54	0.05	0.00
Channel Z	+ Input	199.94	-0.65	-0.33
Channel Z	- Input	-200.24	-1.07	0.54

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-10.58	-12.34
	- 200	13.62	12.01
Channel Y	200	0.32	-0.06
	- 200	-1.09	-1.42
Channel Z	200	7.71	7.74
	- 200	-9.42	-10.09

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-0.84	-2.76
Channel Y	200	5.57	-	0.60
Channel Z	200	9.45	3.54	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16178	15046
Channel Y	16234	13810
Channel Z	15929	16189

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.92	0.34	1.52	0.25
Channel Y	0.02	-1.26	1.35	0.48
Channel Z	-1.46	-2.32	-0.51	0.33

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9